## Notice of References Cited

Application/Control No. 10/784,149	Reexaminati	Applicant(s)/Patent Under Reexamination RICHTER ET AL.	
Examiner	Art Unit		
Marie R. Yamnitzky	1774	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-3,671,451	06-1972	Butterfield	252/301.35
	В	US-5,281,489	01-1994	Mori et al.	428/690
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-	1		-
	1	US-			
	J	US-			
	ĸ	US-			
	L	US-			
	М	US-			<u>, , , , , , , , , , , , , , , , , , , </u>

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name /	Classification
	N.	WO 03/076390 A1	09-2003	WIPO	Nakaya et al.	
	0	WO 2004/026809 A1	04-2004	WIPO	Nakaya et al.	*****
	Р					
	ď					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	u ^	Machine-assisted translation of JP 10-284250 (10/1998).			
	V				
	W				
	×				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.